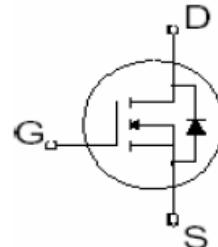


StarMOS<sup>T</sup> Power MOSFET

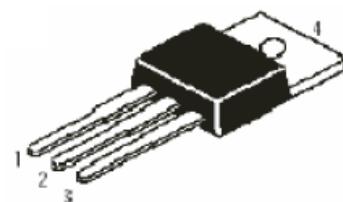
- Extremely high dv/dt capability
- Low Gate Charge Qg results in Simple Drive Requirement
- 100% avalanche tested
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability

**V<sub>DSS</sub> = 600V****I<sub>D25</sub> = 12A****R<sub>DSON</sub> = 0.65 Ω****Description**

StarMOS is a new generation of high voltage N-Channel enhancement mode power MOSFETs. This new technology minimises the JFET effect, increases packing density and reduces the on-resistance. StarMOS also achieves faster switching speeds through optimised gate layout with planar stripe DMOS technology.

**Application**

- Switching application

**TO-220**

Pin1–Gate  
Pin2–Drain  
Pin3–Source

**Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @T <sub>c</sub> =25°C	Continuous Drain Current,V <sub>GS</sub> @10V	12	
I <sub>D</sub> @T <sub>c</sub> =100°C	Continuous Drain Current,V <sub>GS</sub> @10V	7.4	A
I <sub>DM</sub>	Pulsed Drain Current ①	48	
P <sub>D</sub> @T <sub>c</sub> =25°C	Power Dissipation	225	W
	Linear Derating Factor	1.78	W/C
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	870	mJ
I <sub>AR</sub>	Avalanche Current ①	12	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	22.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	4.5	V/ns
T <sub>J</sub>	Operating Junction and		
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	C
	Soldering Temperature, for 10 seconds	300(1.6mm from case)	
	Mounting Torque,6-32 or M3 screw	10 lbf.in(1.1N.m)	

**Thermal Resistance**

	Parameter	Min.	Typ.	Max.	Units
R <sub>JC</sub>	Junction-to-case	—	—	0.56	C/W
R <sub>CS</sub>	Case-to-Sink,Flat,Greased Surface	—	0.50	—	
R <sub>JA</sub>	Junction-to-Ambient	—	—	62.5	



# Taiwan Goodark Technology Co.,Ltd

## SSFP12N60

### Electrical Characteristics @TJ=25°C(unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	600	—	—	V	V <sub>GS</sub> =0V,I <sub>D</sub> =250μA
ΔV <sub>(BR)DSS/ΔTJ</sub>	Breakdown Voltage Temp.Coefficient	—	0.5	—	V/°C	Reference to 25°C,I <sub>D</sub> =250μA
R <sub>DSS(on)</sub>	Static Drain-to-Source On-resistance	—	0.53	0.65	Ω	V <sub>GS</sub> =10V,I <sub>D</sub> =6A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	—	4.0	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA
g <sub>fs</sub>	Forward Transconductance	—	13.0	—	S	V <sub>DS</sub> =40V,I <sub>D</sub> =6A
I <sub>DS</sub>	Drain-to-Source Leakage current	—	—	1	μA	V <sub>DS</sub> =600V,V <sub>GS</sub> =0V
		—	—	10	μA	V <sub>DS</sub> =480V,V <sub>GS</sub> =0V,T <sub>J</sub> =150°C
I <sub>GSS</sub>	Gate-to-Source Forward leakage	—	—	100	nA	V <sub>GS</sub> =30V
	Gate-to-Source Reverse leakage	—	—	-100	nA	V <sub>GS</sub> =-30V
Q <sub>G</sub>	Total Gate Charge	—	48	63	nC	I <sub>D</sub> =12A
Q <sub>GS</sub>	Gate-to-Source charge	—	8.5	—	nC	V <sub>DS</sub> =480V
Q <sub>GD</sub>	Gate-to-Drain("Miller") charge	—	2.1	—	nC	V <sub>GS</sub> =10V
t <sub>d(on)</sub>	Turn-on Delay Time	—	30	70	nS	V <sub>DD</sub> =300V
t <sub>r</sub>	Rise Time	—	85	180	nS	I <sub>D</sub> =12A
t <sub>d(off)</sub>	Turn-Off Delay Time	—	140	280	nS	R <sub>G</sub> =25Ω
t <sub>f</sub>	Fall Time	—	90	190	nS	
L <sub>D</sub>	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm(0.25in.) from package and center of die contact
L <sub>S</sub>	Internal Source Inductance	—	7.5	—	nH	
C <sub>iss</sub>	Input Capacitance	—	1760	2290	pF	V <sub>GS</sub> =0V
C <sub>oss</sub>	Output Capacitance	—	182	235	pF	V <sub>DS</sub> =25V
C <sub>rss</sub>	Reverse Transfer Capacitance	—	21	28	pF	zf=1.0MHz



### Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	12	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	48	A	
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.4	V	T <sub>J</sub> =25°C,I <sub>S</sub> =12A,V <sub>GS</sub> =0V ④
t <sub>rr</sub>	Reverse Recovery Time	—	420	—	nS	T <sub>J</sub> =25°C,I <sub>F</sub> =12A
Q <sub>rr</sub>	Reverse Recovery Charge	—	4.9	—	nC	di/dt=100A/μs ④
t <sub>on</sub>	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> + L <sub>D</sub> )				

Notes:

- ① Repetitive rating;pulse width limited by max.junction temperature
- ③ I<sub>so</sub>≤12A,di/dt≤200A/μs,V<sub>DD</sub>≤V<sub>(BR)DSS</sub>,T<sub>J</sub>≤25°C
- ② L = 11mH, I<sub>AS</sub> = 12 A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C
- ④ Pulse width≤300 μs; duty cycle≤2%